



**N-Channel JFETs**

**J111 SST111**  
**J112 SST112**  
**J113 SST113**

<b>PRODUCT SUMMARY</b>				
<b>Part Number</b>	<b>V<sub>GS(on)</sub> (V)</b>	<b>r<sub>DS(on)</sub> Max (Ω)</b>	<b>I<sub>D(on)</sub> Typ (pA)</b>	<b>t<sub>ON</sub> Typ (ns)</b>
J/SST111	-3 to -10	30	5	4
J/SST112	-1 to -5	50	5	4
J/SST113	≤-3	100	5	4

**FEATURES**

- Low On-Resistance: 111 < 30 Ω
- Fast Switching—t<sub>ON</sub>: 4 ns
- Low Leakage: 5 pA
- Low Capacitance: 3 pF
- Low Insertion Loss

**BENEFITS**

- Low Error Voltage
- High-Speed Analog Circuit Performance
- Negligible "Off-Error," Excellent Accuracy
- Good Frequency Response, Low Glitches
- Eliminates Additional Buffering

**APPLICATIONS**

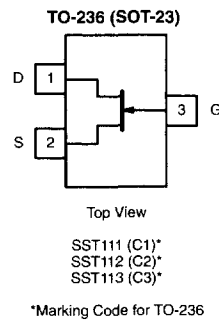
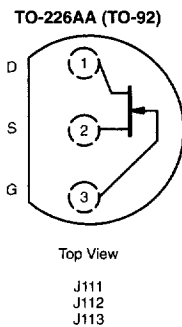
- Analog Switches
- Choppers
- Sample-and-Hold
- Normally "On" Switches
- Current Limiters

**DESCRIPTION**

The J/SST111 series consists of all-purpose analog switches designed to support a wide range of applications. The J/SST113 are useful in a high-gain amplifier mode.

For similar products in TO-206AA(TO-18) packaging, see the 2N/PN/SST4391 series, 2N4856A/4857A/4858A, and 2N5564/5565/5566 (duals) data sheets.

The J series, TO-226AA (TO-92) plastic package, provides low cost, while the SST series, TO236 (SOT-23) package, provides surface-mount capability. Both the J and SST series are available in tape-and-reel for automated assembly (see Packaging Information).



**ABSOLUTE MAXIMUM RATINGS**

Gate-Drain, Gate-Source Voltage	-35 V
Gate Current	50 mA
Lead Temperature (1/16" from case for 10 seconds)	300 °C
Storage Temperature	-55 to 150 °C
Operating Junction Temperature	-55 to 150 °C

Power Dissipation*	
(TO-236)	350 mW
(TO-226AA)	360 mW

Notes  
 a. Derate 2.8 mW/°C above 25 °C

For applications information see AN105.

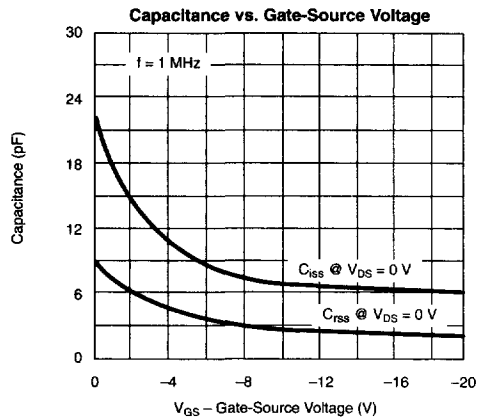
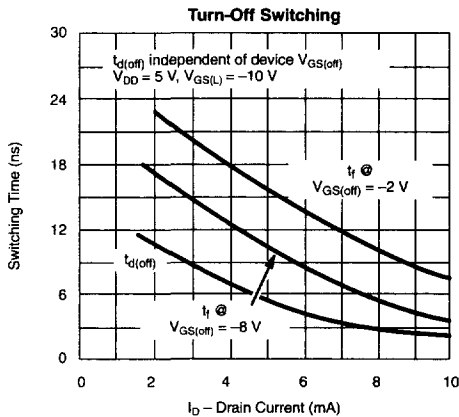
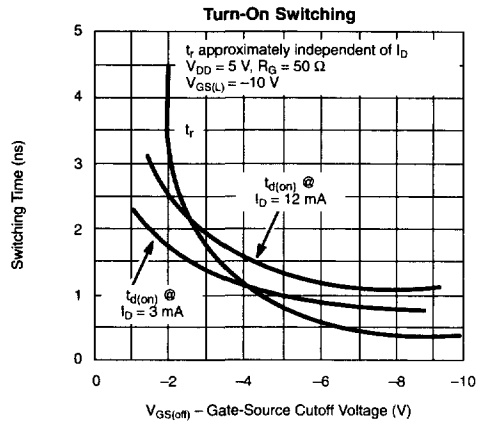
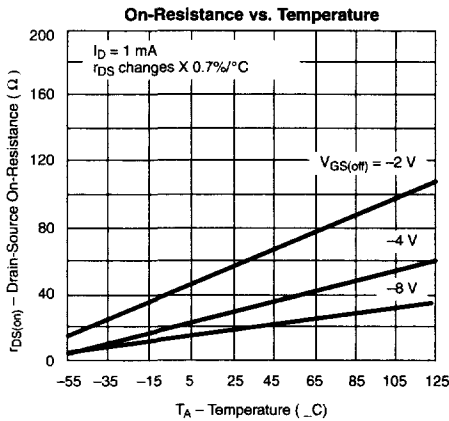
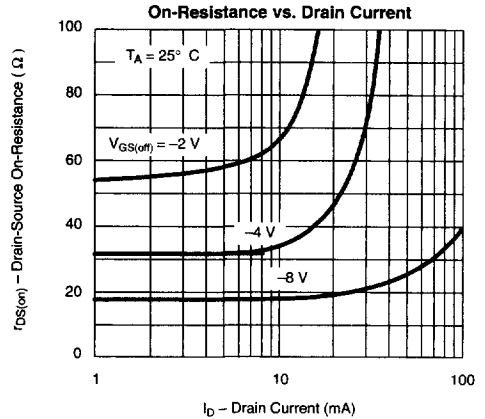
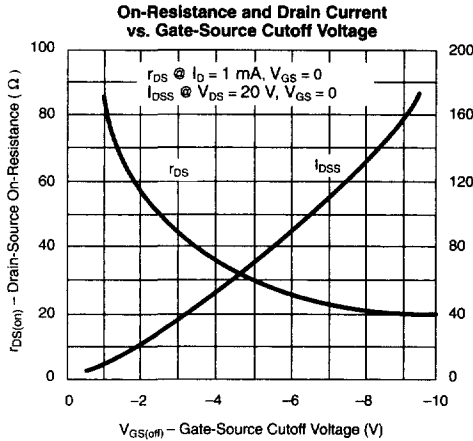


<b>SPECIFICATIONS (T<sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)</b>										
Parameter	Symbol	Test Conditions	Typ <sup>a</sup>	Limits						Unit
				J/SST111		J/SST112		J/SST113		
				Min	Max	Min	Max	Min	Max	
<b>Static</b>										
Gate-Source Breakdown Voltage	V <sub>(BR)GSS</sub>	I <sub>G</sub> = -1 μA, V <sub>DS</sub> = 0 V	-55	-35		-35		-35		V
Gate-Source Cutoff Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 1 μA		-3	-10	-1	-5		-3	
Saturation Drain Current <sup>b</sup>	I <sub>DSS</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V		20		5		2		mA
Gate Reverse Current	I <sub>GSS</sub>	V <sub>GS</sub> = -15 V, V <sub>DS</sub> = 0 V	-0.005		-1		-1		-1	nA
		T <sub>A</sub> = 125°C	-3							
Gate Operating Current	I <sub>G</sub>	V <sub>DG</sub> = 15 V, I <sub>D</sub> = 10 mA	-5							pA
Drain Cutoff Current	I <sub>D(off)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = -10 V	0.005		1		1		1	nA
		T <sub>A</sub> = 125°C	3							
Drain-Source On-Resistance	r <sub>DS(on)</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0.1 V			30		50		100	Ω
Gate-Source Forward Voltage	V <sub>GS(F)</sub>	I <sub>G</sub> = 1 mA, V <sub>DS</sub> = 0 V	0.7							V
<b>Dynamic</b>										
Common-Source Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 1 mA f = 1 kHz	6							mS
			25							μS
Common-Source Output Conductance	g <sub>os</sub>									μS
Drain-Source On-Resistance	r <sub>DS(on)</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 0 mA f = 1 kHz			30		50		100	Ω
Common-Source Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = -10 V f = 1 MHz	7		12		12		12	pF
			3		5		5		5	
Common-Source Reverse Transfer Capacitance	C <sub>rss</sub>									pF
Equivalent Input Noise Voltage	e <sub>n</sub>	V <sub>DG</sub> = 10 V, I <sub>D</sub> = 1 mA f = 1 kHz	3							nV/ √Hz
<b>Switching</b>										
Turn-On Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, V <sub>GS(±)</sub> = 0 V See Switching Circuit	2							ns
	t <sub>r</sub>		2							
Turn-Off Time	t <sub>d(off)</sub>		6							
	t <sub>f</sub>		15							

Notes  
a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.  
b. Pulse test: PW ≤ 300 μs duty cycle ≤ 3%.

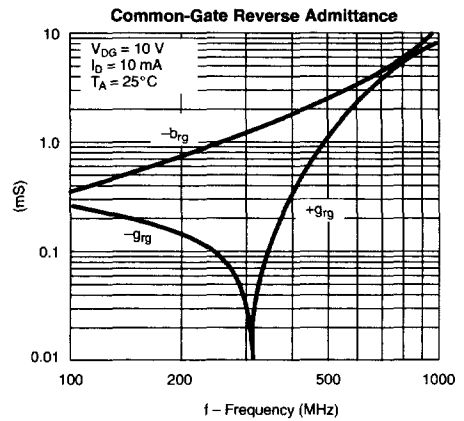
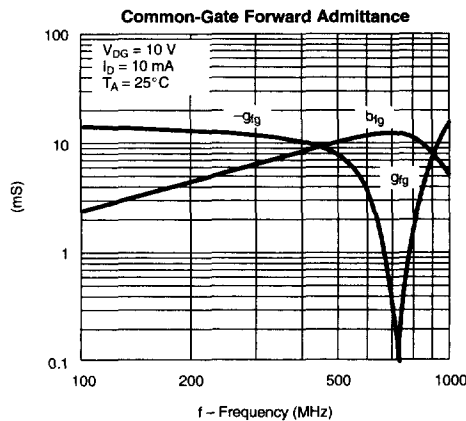
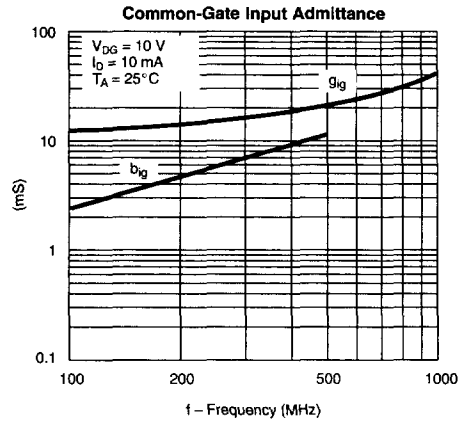
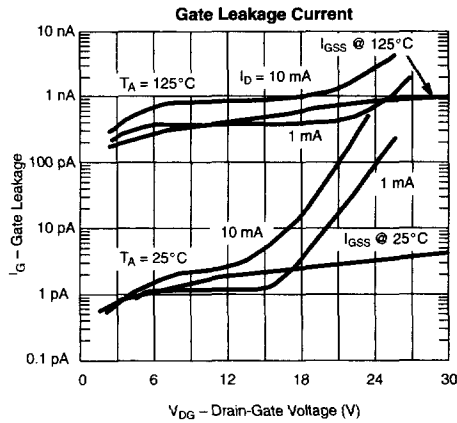
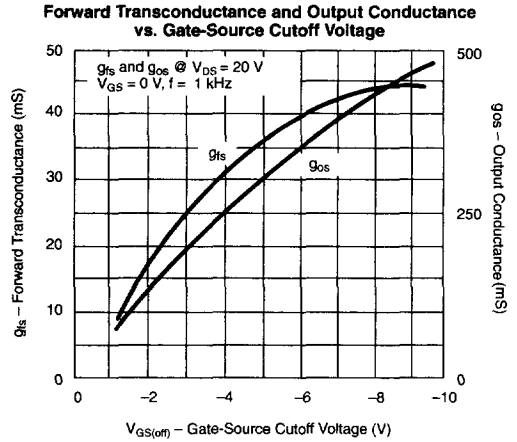
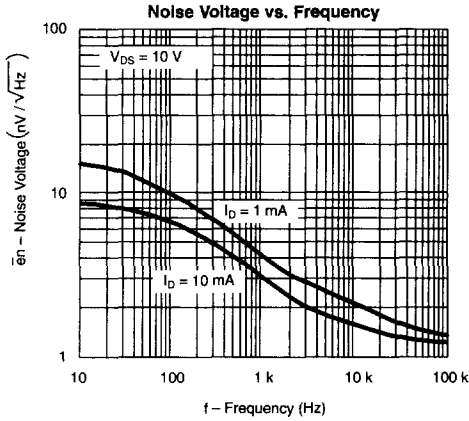


**TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)**



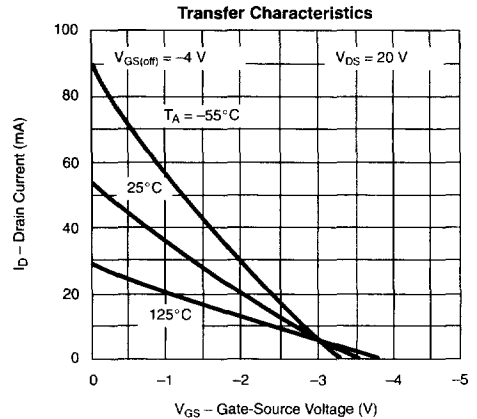
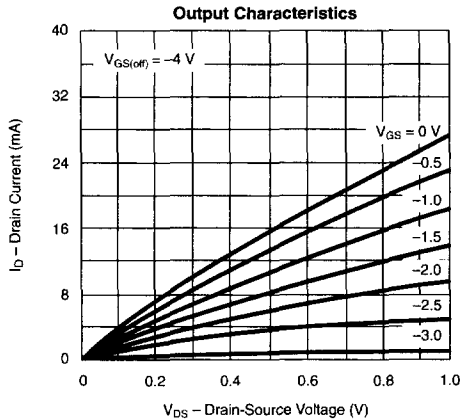
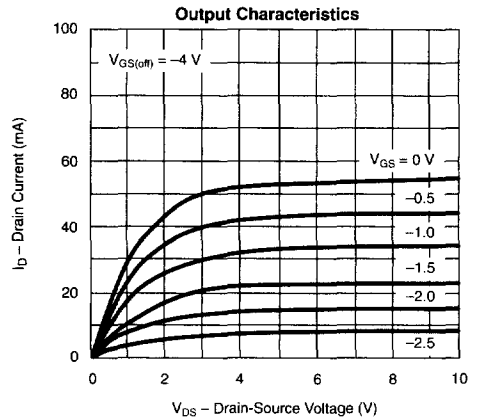
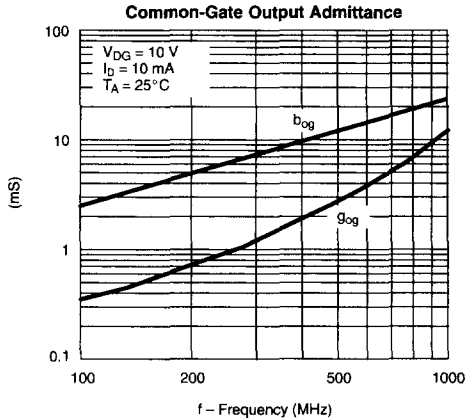


**TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)**





**TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  UNLESS OTHERWISE NOTED)**



<b>SWITCHING TIME TEST CIRCUIT</b>			
	<b>J/SST111</b>	<b>J/SST112</b>	<b>J/SST113</b>
$V_{GS(L)}$	-12 V	-7 V	-5 V
$R_L^*$	800 $\Omega$	1600 $\Omega$	3200 $\Omega$
$I_{D(on)}$	12 mA	6 mA	3 mA

\*Non-inductive

**INPUT PULSE**

Rise Time < 1 ns  
 Fall Time < 1 ns  
 Pulse Width 100 ns  
 PRF 1 MHz

**SAMPLING SCOPE**

Rise Time 0.4 ns  
 Input Resistance 10 M $\Omega$   
 Input Capacitance 1.5 pF

